

Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	31	40	C/W				
Maximum Junction-to-Ambient ^A	Steady State	$R_{ extsf{ heta}JA}$	59	75	C/W				
Maximum Junction-to-Lead ^C	Steady State	$R_{ ext{ heta}JL}$	16	24	°C/W				

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	$I_{D} = -250 \mu A, V_{GS} = 0 V$	-40			V				
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -40V, V_{GS} = 0V$			-1	μA				
		T _J = 55℃			-5	μι				
I _{GSS}	Gate-Body leakage current	$V_{DS} = 0V, V_{GS} = \pm 20V$			±100	nA				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS} I_D = -250 \mu A$	-1.7	-1.9	-2.5	V				
I _{D(ON)}	On state drain current	$V_{GS} = -10V, V_{DS} = -5V$	-120			A				
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = -10V, I_{D} = -10A$		12.5	15					
		T _J =125℃		19	23	mΩ				
		$V_{GS} = -4.5V, I_{D} = -8A$		16	20					
g _{FS}	Forward Transconductance	$V_{DS} = -5V, I_{D} = -10A$		25		S				
V_{SD}	Diode Forward Voltage	$I_{S} = -1A, V_{GS} = 0V$		-0.7	-1	V				
I _S	Maximum Body-Diode Continuous Curr			-3	A					
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			2500	3000	pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-20V, f=1MHz		260		pF				
C _{rss}	Reverse Transfer Capacitance			180		pF				
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	2.5	4	6	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			42	55	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-20V, I _D =-10A		18.6		nC				
Q _{gs}	Gate Source Charge	$v_{GS} = 10^{\circ}, v_{DS} = 20^{\circ}, v_{D} = 10^{\circ}$		7		nC				
Q _{gd}	Gate Drain Charge	7		8.6		nC				
t _{D(on)}	Turn-On DelayTime			9.4		ns				
t _r	Turn-On Rise Time	V _{GS} =-10V, V _{DS} =-20V,		20		ns				
t _{D(off)}	Turn-Off DelayTime	$R_L = 2\Omega, R_{GEN} = 3\Omega$		55		ns				
t _f	Turn-Off Fall Time			30		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =-10A, dI/dt=100A/μs		38	49	ns				
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =-10A, dI/dt=100A/μs		47		nC				

Electrical Characteristics (T_J=25°C unless otherwise noted)

A: The value of R_{0JA} is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm \theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm \theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using t \leqslant 300 μs pulses, duty cycle 0.5% max.

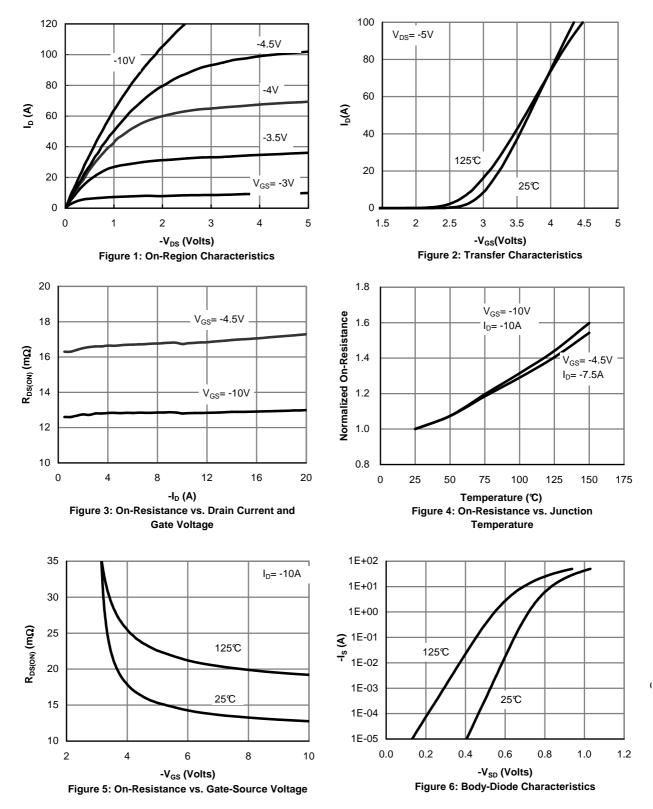
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^{\circ}$ C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leqslant 10s thermal resistance rating.

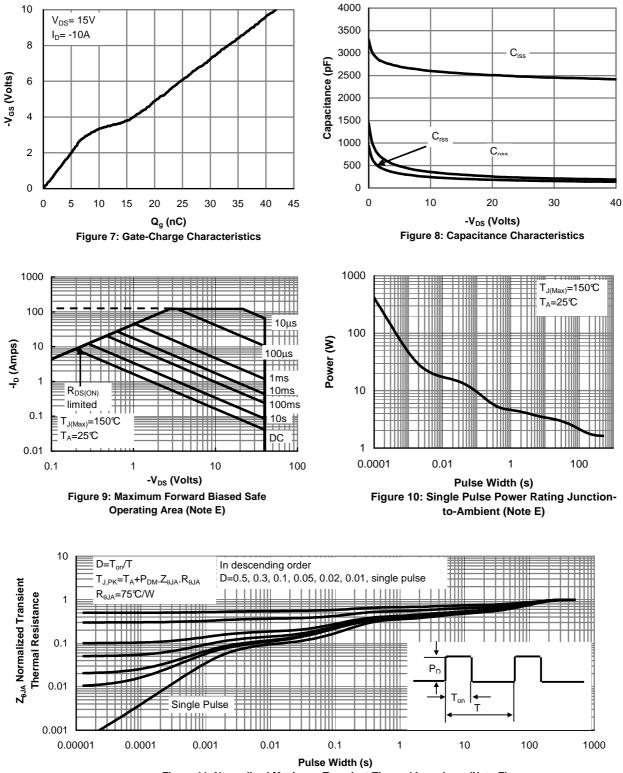
G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j =25C.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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Figure 11: Normalized Maximum Transient Thermal Impedance(Note E)

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